



High-end Power Semiconductor Manufacturer

# ZK630A 1000-1800V

## Fast Recovery Diode

- Low switching losses
- Low reverse recovery charge High
- power cycling capability



Average forward current		I <sub>FAV</sub>	630 A		
Repetitive peak reverse voltage		V <sub>RRM</sub>	1000 – 1800 V		
Reverse recovery time		t <sub>rr</sub>	3.2 µs		
V <sub>RRM</sub> , V	1000	1200	1400	1600	1800
Voltage code	10	12	14	16	18
T <sub>j</sub> , °C	– 60 – 125				

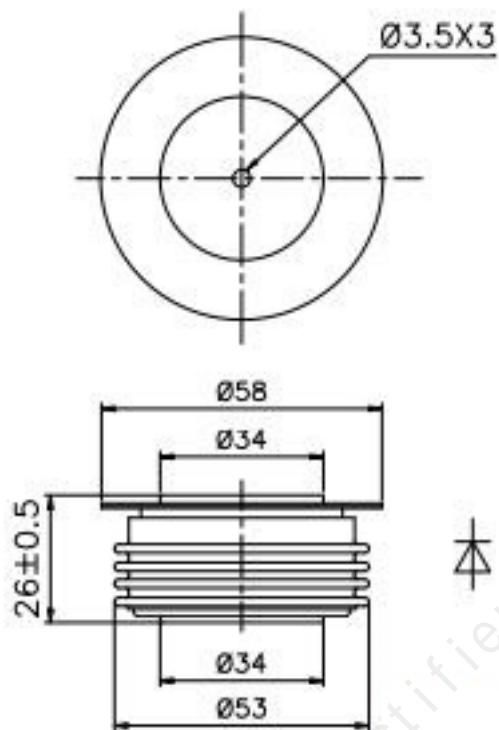
### MAXIMUM ALLOWABLE RATINGS

Symbols and parameters		Units	Values	Test conditions	
<b>ON-STATE</b>					
I <sub>FAV</sub>	Average forward current	A	630	T <sub>c</sub> =85°C; Double side cooled; 180° half-sine wave; 50 Hz	
I <sub>FRMS</sub>	RMS forward current	A	989	T <sub>c</sub> =85°C; Double side cooled; 180° half-sine wave; 50 Hz	
I <sub>FSM</sub>	Surge forward current	kA	14.0	T <sub>j</sub> =T <sub>j</sub> max T <sub>j</sub> =25 °C	180° half-sine wave; 50 Hz (t <sub>p</sub> =10 ms); single pulse; V <sub>R</sub> =0 V;
			16.0	T <sub>j</sub> =T <sub>j</sub> max T <sub>j</sub> =25 °C	180° half-sine wave; 60 Hz (t <sub>p</sub> =8.3 ms); single pulse; V <sub>R</sub> =0 V;
I <sup>2</sup> t	Safety factor	A <sup>2</sup> s·10 <sup>3</sup>	980	T <sub>j</sub> =T <sub>j</sub> max T <sub>j</sub> =25 °C	180° half-sine wave; 50 Hz (t <sub>p</sub> =10 ms); single pulse; V <sub>R</sub> =0 V;
			1280	T <sub>j</sub> =T <sub>j</sub> max T <sub>j</sub> =25 °C	180° half-sine wave; 60 Hz (t <sub>p</sub> =8.3 ms); single pulse; V <sub>R</sub> =0 V;
<b>BLOCKING</b>					
V <sub>RRM</sub>	Repetitive peak reverse voltages	V	1000–1800	T <sub>j min</sub> < T <sub>j </sub> <T <sub>j max</sub> ; 180° half-sine wave; 50 Hz;	
V <sub>RSM</sub>	Non-repetitive peak reverse voltages	V	1100–1900	T <sub>j min</sub> < T <sub>j </sub> <T <sub>j max</sub> ; 180° half-sine wave; 50 Hz;single pulse;	
V <sub>R</sub>	Reverse continuous voltages	V	0.75·V <sub>RRM</sub>	T <sub>j</sub> =T <sub>j</sub> max;	
<b>THERMAL</b>					
T <sub>stg</sub>	Storage temperature	°C	– 60 – 125		
T <sub>j</sub>	Operating junction temperature	°C	– 60 – 125		
<b>MECHANICAL</b>					
F	Mounting force	kN	14.0 – 16.0		
a	Acceleration	m/s <sup>2</sup>	50 100	Device unclamped Device clamped	

## CHARACTERISTICS

Symbols and parameters		Units	Values	Conditions
<b>ON-STATE</b>				
V <sub>FM</sub>	Peak forward voltage, max	V	2.30	T <sub>j</sub> =25 °C; I <sub>FM</sub> =1978 A
V <sub>F(TO)</sub>	Forward threshold voltage, max	V	1.20	T <sub>j</sub> =T <sub>j</sub> max;
r <sub>T</sub>	Forward slope resistance, max	mΩ	0.300	0.5 π I <sub>FAV</sub> < I <sub>T</sub> < 1.5 π I <sub>FAV</sub>
<b>BLOCKING</b>				
I <sub>RRM</sub>	Repetitive peak reverse current, max	mA	35	T <sub>j</sub> =T <sub>j</sub> max; V <sub>R</sub> =V <sub>RRM</sub>
<b>SWITCHING</b>				
Q <sub>rr</sub>	Total recovered charge, max	μC	110	T <sub>j</sub> =T <sub>j</sub> max; I <sub>FM</sub> = I <sub>FAV</sub> ;
t <sub>rr</sub>	Reverse recovery time, max	μs	2.6	di <sub>R</sub> /dt=-100 A/μs;
I <sub>rrM</sub>	Peak reverse recovery current, max	A	188	V <sub>R</sub> =100 V;
<b>THERMAL</b>				
R <sub>thjc</sub>	Thermal resistance, junction to case, max	°C/W	0.0350	Double side cooled
R <sub>thjc-A</sub>			0.0770	Direct current Anode side cooled
R <sub>thjc-K</sub>			0.0630	Cathode side cooled
R <sub>thck</sub>	Thermal resistance, case to heatsink, max	°C/W	0.0060	Direct current
<b>MECHANICAL</b>				
w	Weight, typ	g	280	
D <sub>s</sub>	Surface creepage distance	mm (inch)	33.30 (1.311)	
D <sub>a</sub>	Air strike distance	mm (inch)	22.50 (0.886)	

## OVERALL DIMENSIONS



ZT40

All dimensions in millimeters

**Fig 1 – On-state characteristics of Limit device**

Analytical function for On-state characteristic:

$$V_F = A + B \cdot i_F + C \cdot \ln(i_F + 1) + D \cdot \sqrt{i_F}$$

	Coefficients for max curves	
	$T_j = 25^\circ\text{C}$	$T_j = T_{j\max}$
<b>A</b>		
<b>B</b>		
<b>C</b>		
<b>D</b>		

**On-state characteristic model (see Fig. 1)**

## **Fig 2 – Transient thermal impedance**

Analytical function for Transient thermal impedance junction to case  $Z_{thjc}$  for DC:

$$Z_{thjc} = \sum_{i=1}^n R_i \left( 1 - e^{-\frac{t}{\tau_i}} \right)$$

Where  $i = 1$  to  $n$ ,  $n$  is the number of terms in the series.

$t$  = Duration of heating pulse in seconds.

$Z_{thjc}$  = Thermal resistance at time t.

$R_i$  = Amplitude of  $p_{th}$  term.

$\tau_i$  = Time constant of  $r_{th}$  term.

DC Double side cooled

i	1	2	3	4	5	6
$R_i$ , K/W						
$\tau_i$ , s						

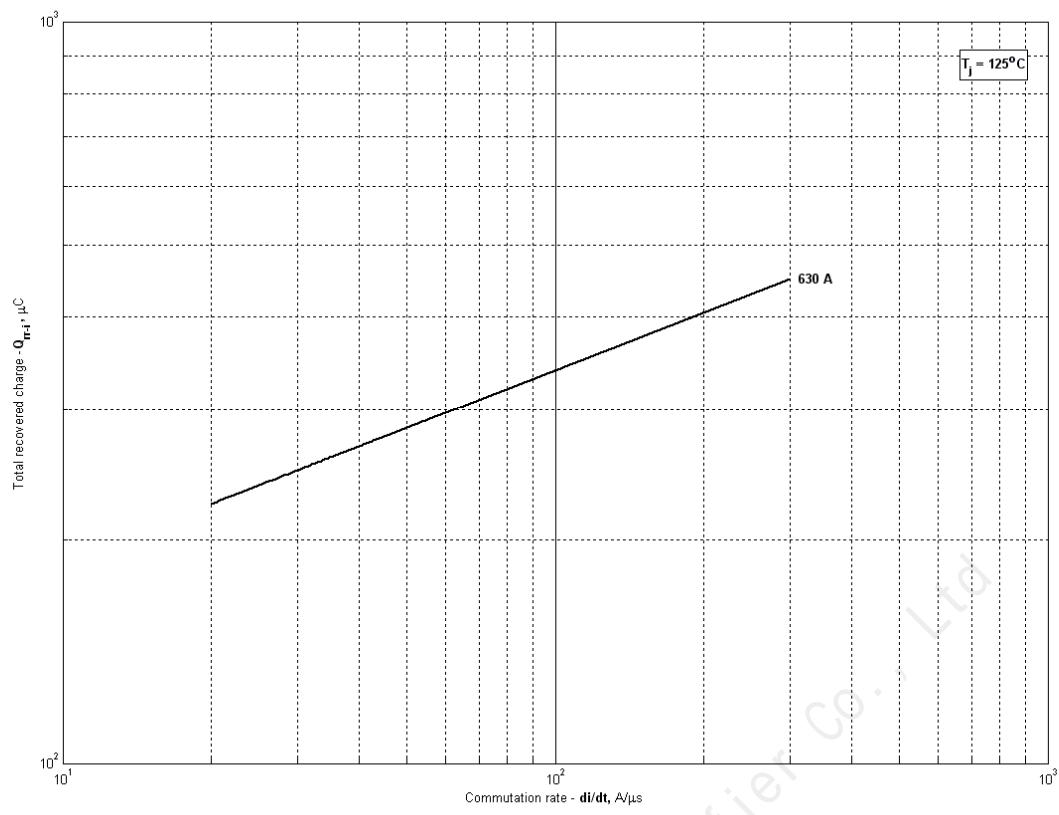
DC Anode side cooled

i	1	2	3	4	5	6
$R_i$ , K/W						
$\tau_i$ , s						

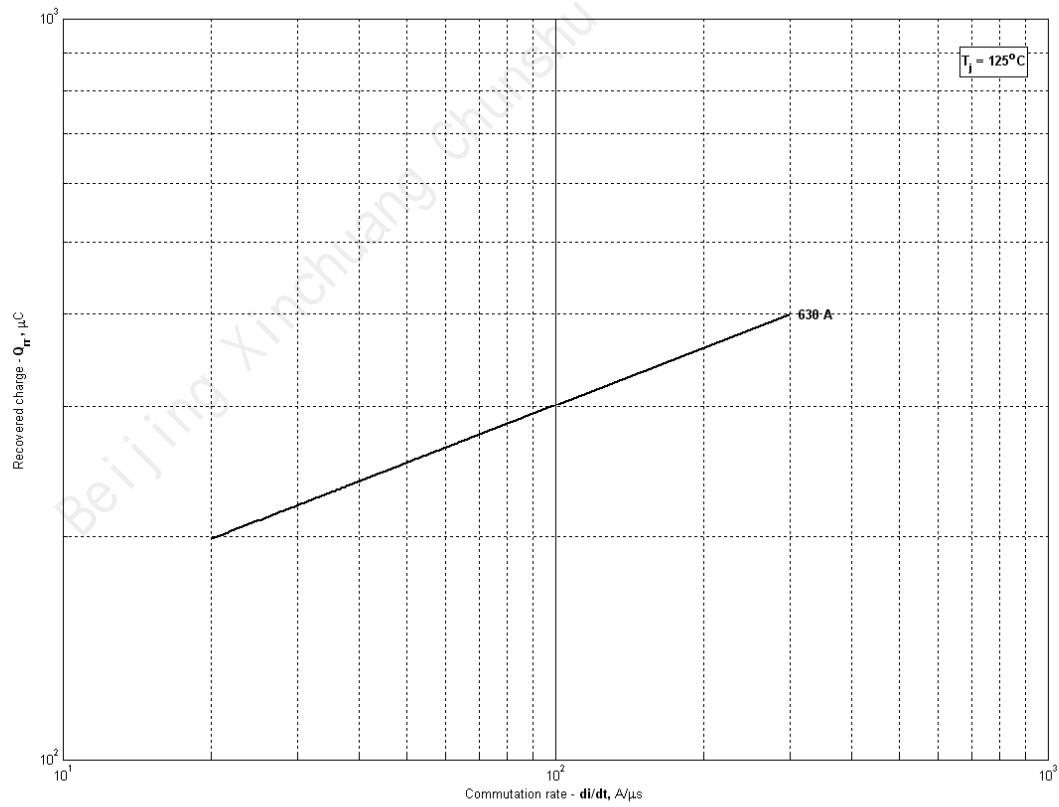
DC Cathode side cooled

i	1	2	3	4	5	6
$R_i$ , K/W						
$\tau_i$ , s						

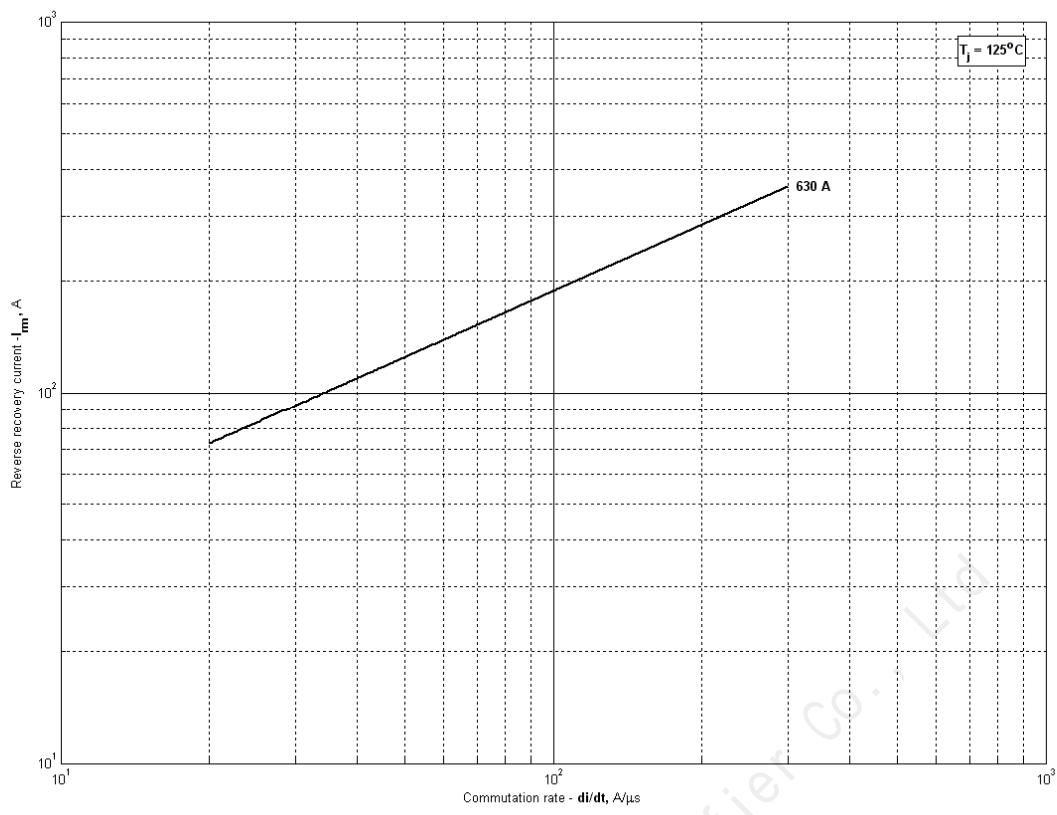
**Transient thermal impedance junction to case  $Z_{thjc}$  model (see Fig. 2)**



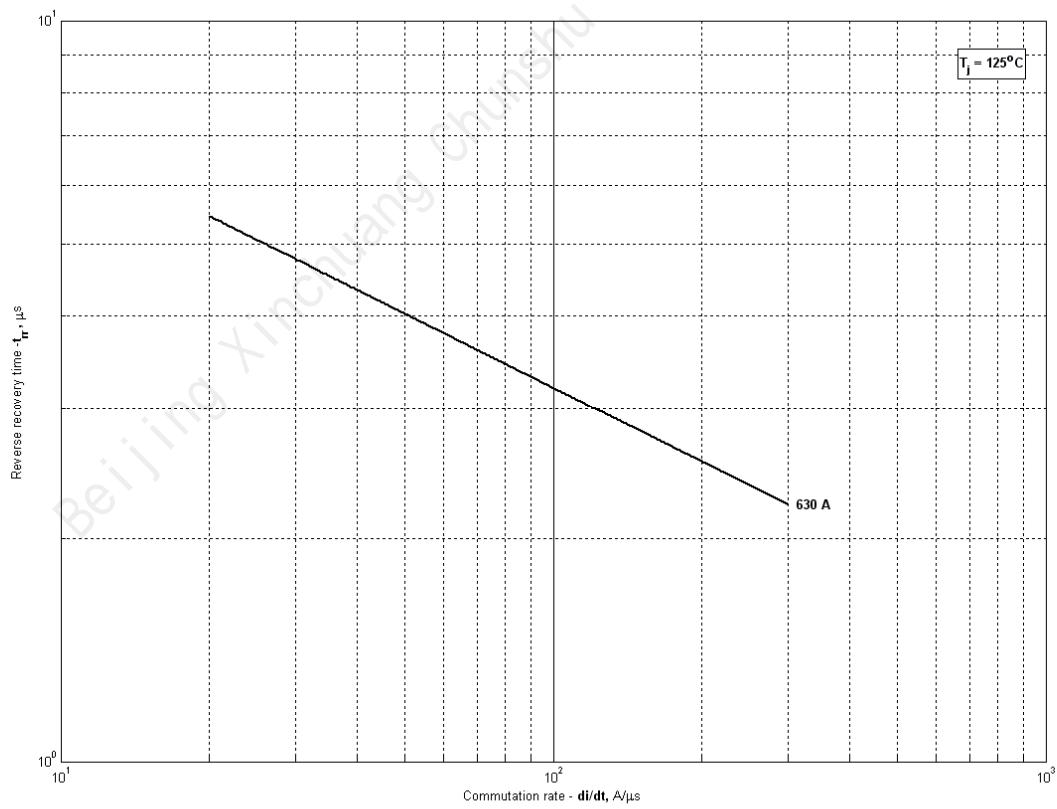
**Fig 3 – Total recovered charge,  $Q_{rr-i}$  (integral)**



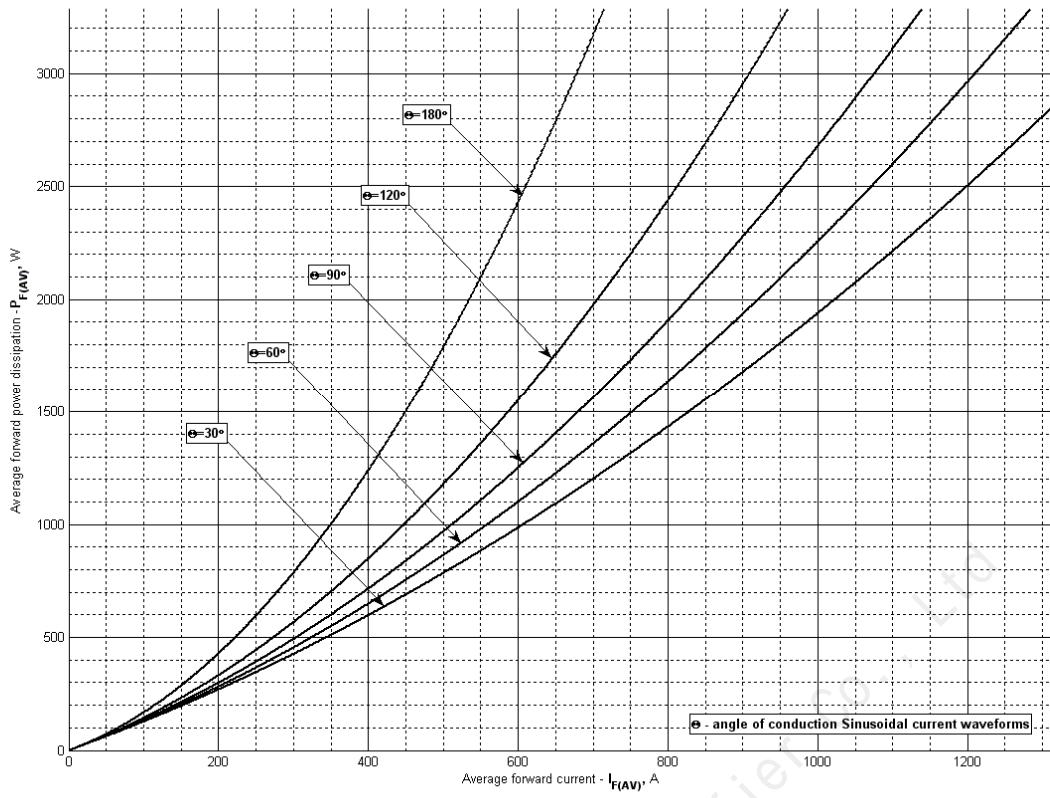
**Fig 4 - Recovered charge,  $Q_{rr}$  (linear)**



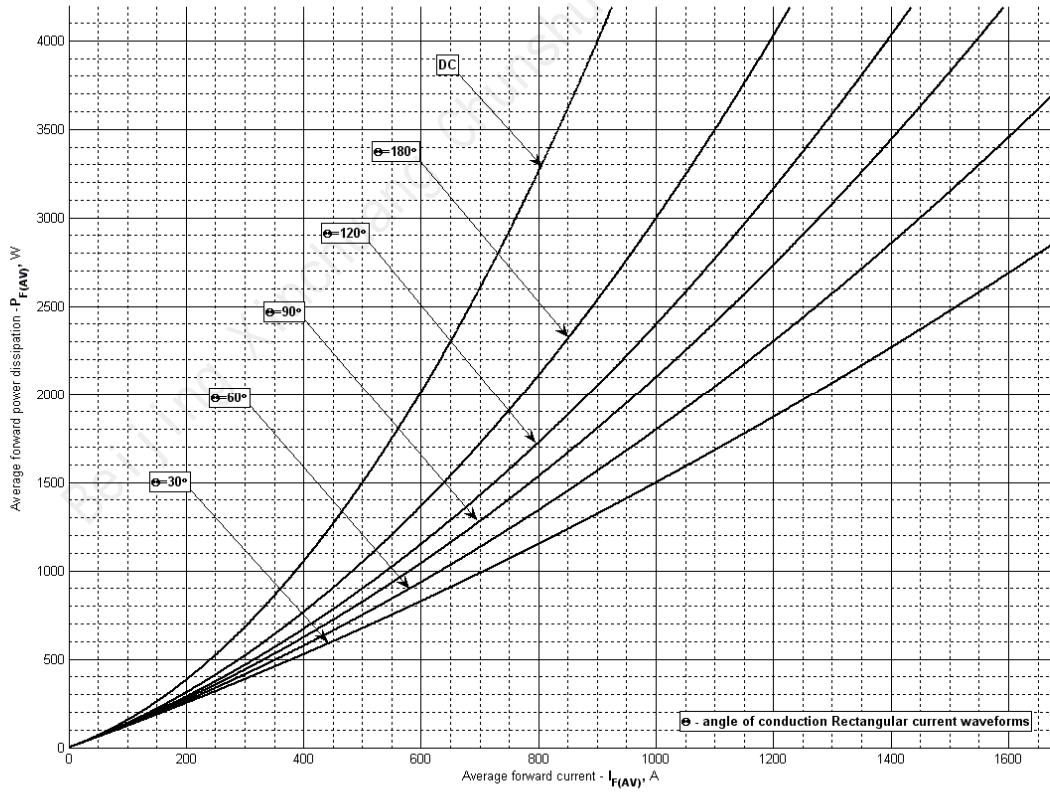
**Fig 5 – Peak reverse recovery current,  $I_{rm}$**



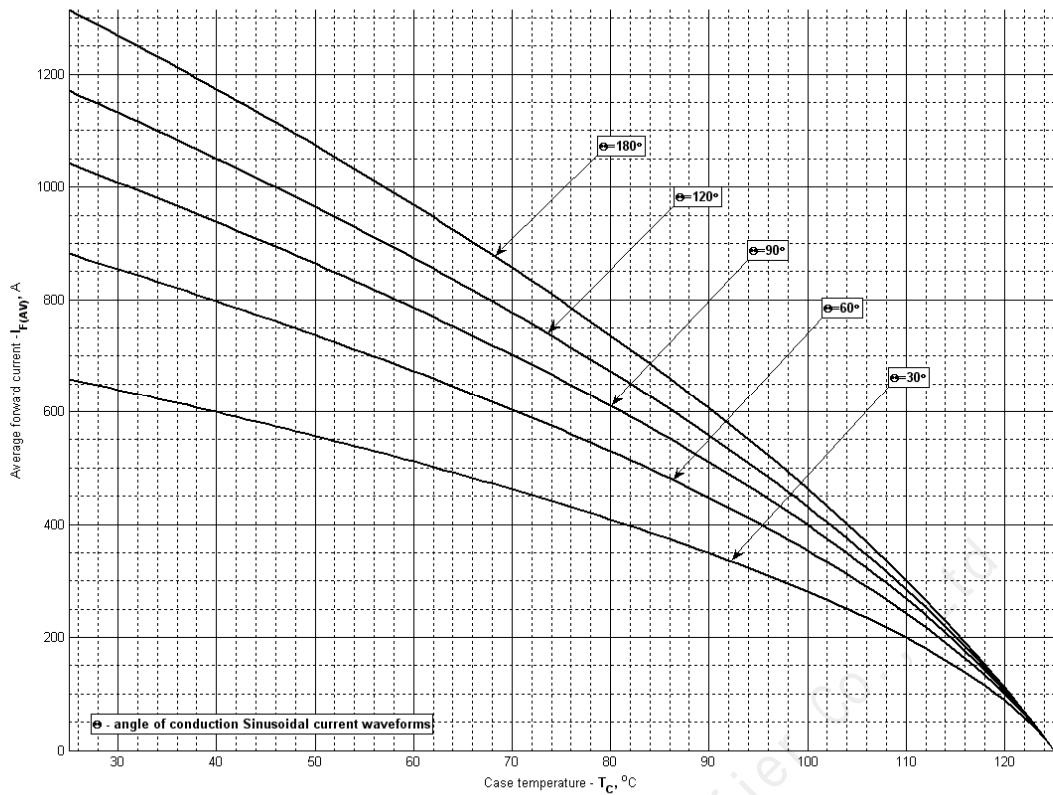
**Fig 6 – Maximum recovery time,  $t_{rr}$  (linear)**



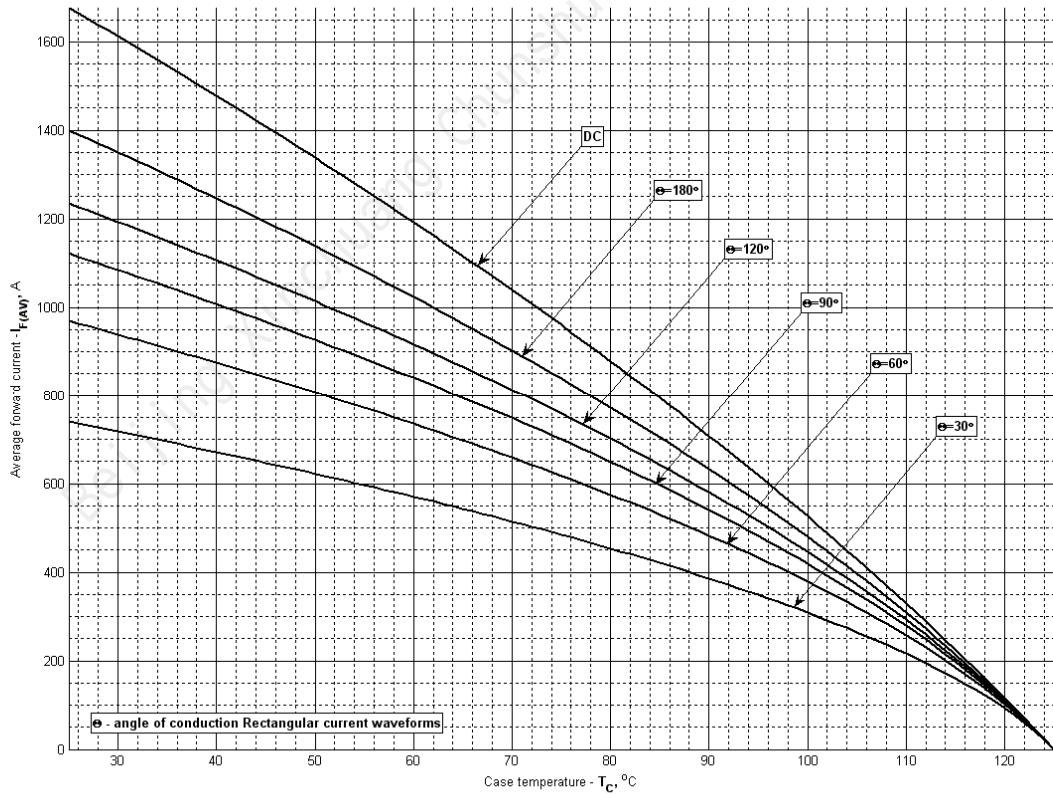
**Fig 7 – On-state power loss (sinusoidal current waveforms)**



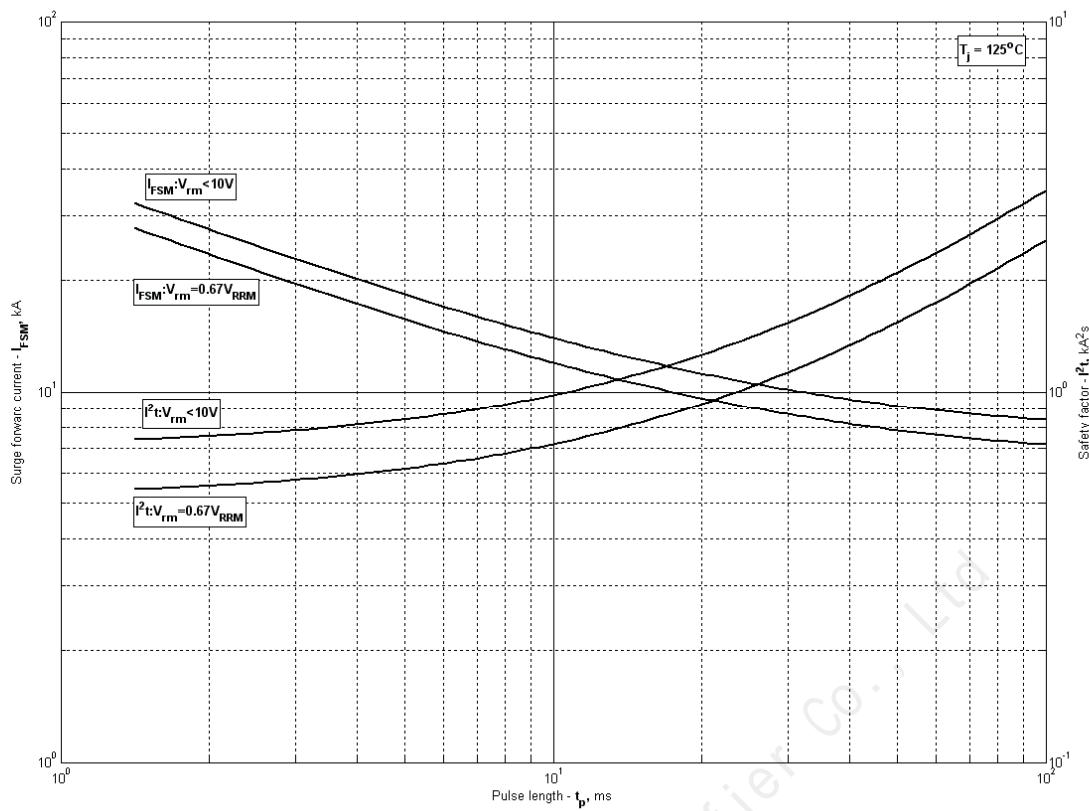
**Fig 8 – On-state power loss (rectangular current waveforms)**



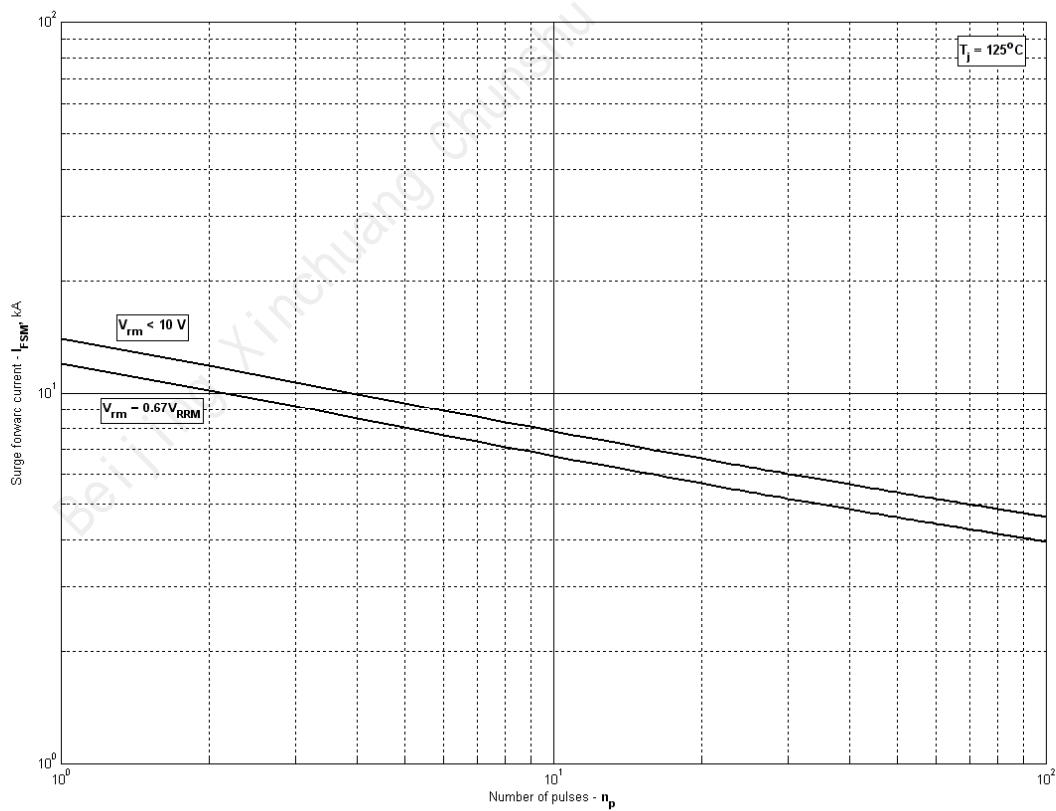
**Fig 9 – Maximum case temperature DSC (sinusoidal current waveforms)**



**Fig 10 – Maximum case temperature DSC (rectangular current waveforms)**



**Fig 11 – Maximum surge and  $I^2t$  ratings**



**Fig 12 – Maximum surge ratings**